	• •		ATTY. D 20110/00	OCKET NO. 401	1 -	SERIAL NO. 10/090,102					
	RMATION DISC EMENT BY AP		APPLICA Alex G. Z	* *							
FORM PTO-1449 U.S. P			FILING DATE GROUP March 2, 2002 2161 2857								
DEMARK G		U. S. I	PATENT DOCU	JMENTS							
EXAMINER INITIAL	PATENT NUMBER	PATENT DATE		NAME						FILING DATE	
ll	4,956,783	September 11	, 1990	Teranishi et al.	R	RECEIVED		:U	<u> </u>	\perp	
	5,479,361 December 2		, 1995	Kurtzberg et al.	ם	C 1	3 20	102			_
	5,862,054 January 19,		1999	Li		Technolog		er 2	00		
	5,896,293 April 20, 19		999	Teramoto et al.	18CI	10105	,	3	5		
	5,946, 661	August 31, 1	1999	Rothschild et al.					5	g	
	6,038,486	March 14, 2	2000	Saitoh et al.		L		2		<u> </u>	
	6,115,643	September 5,	2000	Stine et al.				e	 	12	_
	6,128,540	October 3, 2	2000	Van Der Vegt et al.	_			ğ	3	82	١
	6,211,905	April 3, 20	001	Rudt et al.				5	5		
1	6,249,715	June 19, 20	001	Yuri et al.	REC	Ė۱	/ED				_
V	6,381,509	April 30, 20	. 002	Thiel et al. DEC 1 3		2002					
<i>િ</i> ડ્ય	6,415,191	415,191 July 2, 200		Pryor							`
		U.S. PATENT	APPLICATION	PUBLICATIONS	Technolog	Jy Ce	inei Z	100			_
EXAMINER INITIAL	PUBLICATION NUMBER	i i		NAME	CLA	ss	SUBCL	.ASS	FII DA	UNG	
lish	2001/0025225	September 27	, 2001	Ota et al.	}		1				
lm	2002/0071603	June 13, 20	002	Ungpiyakul et al.	_ (/				_
		01	THER DOCUM	ENTS						1	
EXAMINER INITIAL			AUTHOR, TITL	E, DATE, PERTINENT P	AGES, ETC.						_
pm	Hersh Kohli et. al, E-manufacturing Software for Product and Process Real-time Monitoring, 5 pages, http://www.manufacturingpulse.com/news_events/smta_oct_2001_manufacturing_pulse.pdf										
PAP	Gensym Corp., Real-time Monitoring Diagnosis, Control and Process Optimization, 3 pages http://www.gensym.com/manufacturing/										
POV	Syscon I	nt'i, Inc., Data Collection M	Aodules, 4 pages	, http://www.syscon-plants	star.com/litera	ture/do	m.pdf				
EXAMINER	DATE CONSIDERED 11/5/07					-					

APR 1 8 2002 ESTADEMPORTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

FORM PTO-1449

ATTY. DOCKET NO. 20110/00401

SERIAL NO. 10/090,102

APPLICANT(S)

Alex G. ZEIF

FILING DATE March 2, 2002 GROUP 2857

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE NAME		CLASS	SUBCLASS	FILING DATE	
600-	4,718,025	January 5, 1988	Minor et al.				
	4,802,094	January 31, 1989	Nakamura et al.				
	5,586,041	December 17, 1996	Mangrulkar				
	5,691,895	November 25, 1997	Kurtzberg et al.				
5,821,990		October 13, 1998	Rudt et al.				
	5,970,476	October 19, 1999	Fahey				
	6,115,643	September 5, 2000	Stine et al.				
V	6,144,885	November 7, 2000	Scarrah		1		
POD	6,295,510 B1	September 25, 2001	Discenzo		1 1		

FOREIGN PATENT DOCUMENTS

						TRANSLATION	
EXAMINER INITIAL	DOCUMENT NUMBER	DATE (M/D/Y)	COUNTRY	CLASS	SUBCLASS	YES	NO
	·						
							<u> </u>
							l

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.

EXAMINER

~, C

DATE CONSIDERED

15/07

EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.